

<b>Notice of References Cited</b>	Application/Control No. 09/994,809	Applicant(s)/Patent Under Reexamination YOO ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,528,357	03-2003	Dojo et al.	438/151
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 11-259016	09-1999	Japan	Dojiro et al	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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